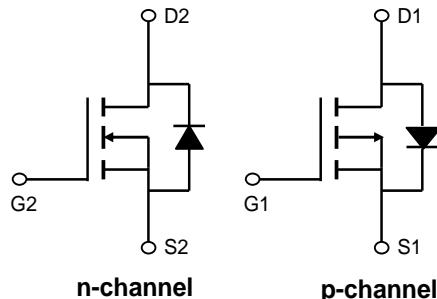


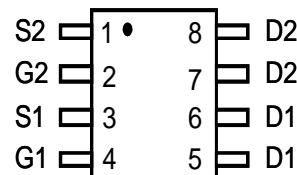
## General Description

The AO4614 uses advanced trench technology MOSFETs to provide excellent  $R_{DS(ON)}$  and low gate charge. The complementary MOSFETs may be used in H-bridge, Inverters and other applications.



## Product Summary

N-Channel	P-Channel
$V_{DS}$ (V) = 40V,	-40V
$I_D$ = 6A ( $V_{GS}$ =10V)	-5A ( $V_{GS}$ = -10V)
$R_{DS(ON)}$	
< 20mΩ ( $V_{GS}$ =10V)	< 39mΩ ( $V_{GS}$ = -10V)
< 26mΩ ( $V_{GS}$ =4.5V)	< 50mΩ ( $V_{GS}$ = -4.5V)



## Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Max n-channel	Max p-channel	Units
Drain-Source Voltage	$V_{DS}$	40	-40	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	$\pm 20$	V
Continuous Drain Current <sup>A</sup>	$I_D$	6	-5	A
$T_A=70^\circ\text{C}$		5	-4	
Pulsed Drain Current <sup>B</sup>	$I_{DM}$	30	-30	
Avalanche Current <sup>B</sup>	$I_{AR}$	14	-20	
Repetitive avalanche energy $L=0.1\text{mH}$ <sup>B</sup>	$E_{AR}$	9.8	20	mJ
Power Dissipation	$P_D$	2	2	W
$T_A=25^\circ\text{C}$		1.28	1.28	
$T_A=70^\circ\text{C}$				
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	-55 to 150	°C

## Thermal Characteristics: n-channel and p-channel

Parameter	Symbol	Device	Typ	Max	Units
Maximum Junction-to-Ambient <sup>A</sup>	$R_{\theta JA}$	n-ch	48	62.5	°C/W
Steady-State		n-ch	74	110	°C/W
Maximum Junction-to-Lead <sup>C</sup>	$R_{\theta JL}$	n-ch	35	50	°C/W
Steady-State		p-ch	48	62.5	°C/W
Maximum Junction-to-Ambient <sup>A</sup>	$R_{\theta JA}$	p-ch	74	110	°C/W
Steady-State		p-ch	35	50	°C/W
Maximum Junction-to-Lead <sup>C</sup>					

N Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	40			V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{DS}=40\text{V}, V_{GS}=0\text{V}$			1	$\mu\text{A}$
		$T_J=55^\circ\text{C}$			5	
$I_{\text{GSS}}$	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$			$\pm 100$	nA
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.7	2.5	3	V
$I_{\text{D(ON)}}$	On state drain current	$V_{GS}=10\text{V}, V_{DS}=5\text{V}$	30			A
$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=6\text{A}$		24	30	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=5\text{A}$		30	38	
$g_{\text{FS}}$	Forward Transconductance	$V_{DS}=5\text{V}, I_D=6\text{A}$		19		S
$V_{\text{SD}}$	Diode Forward Voltage	$I_S=1\text{A}, V_{GS}=0\text{V}$		0.76	1	V
$I_S$	Maximum Body-Diode Continuous Current				2	A
<b>DYNAMIC PARAMETERS</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=20\text{V}, f=1\text{MHz}$	410	516	650	pF
$C_{\text{oss}}$	Output Capacitance			82		pF
$C_{\text{rss}}$	Reverse Transfer Capacitance			43		pF
$R_g$	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$		4.6		$\Omega$
<b>SWITCHING PARAMETERS</b>						
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=10\text{V}, V_{DS}=20\text{V}, I_D=6\text{A}$		8.9	10.8	nC
$Q_g(4.5\text{V})$	Total Gate Charge			4.3	5.6	nC
$Q_{\text{gs}}$	Gate Source Charge			2.4		nC
$Q_{\text{gd}}$	Gate Drain Charge			1.4		nC
$t_{\text{D(on)}}$	Turn-On DelayTime	$V_{GS}=10\text{V}, V_{DS}=20\text{V}, R_L=3.3\Omega, R_{\text{GEN}}=3\Omega$		6.4		ns
$t_r$	Turn-On Rise Time			3.6		ns
$t_{\text{D(off)}}$	Turn-Off DelayTime			16.2		ns
$t_f$	Turn-Off Fall Time			6.6		ns
$t_{\text{rr}}$	Body Diode Reverse Recovery Time	$I_F=6\text{A}, dI/dt=100\text{A}/\mu\text{s}$		18	24	ns
$Q_{\text{rr}}$	Body Diode Reverse Recovery Charge	$I_F=6\text{A}, dI/dt=100\text{A}/\mu\text{s}$		10		nC

A: The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design. The current rating is based on the  $t \leq 10\text{s}$  thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using <300  $\mu\text{s}$  pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The SOA curve provides a single pulse rating.

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: N-CHANNEL

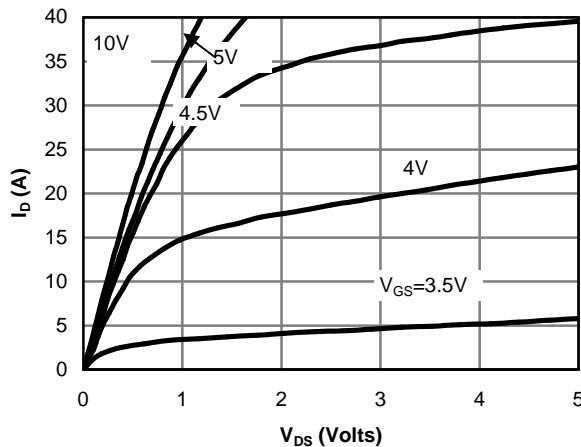


Fig 1: On-Region Characteristics

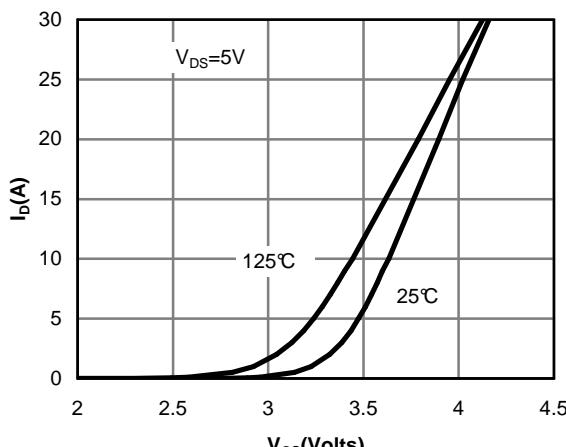


Figure 2: Transfer Characteristics

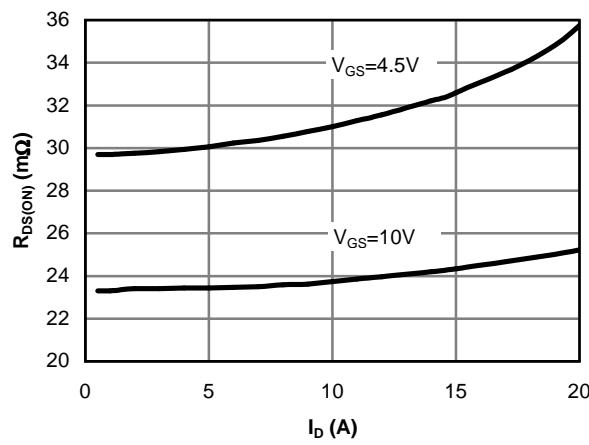


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

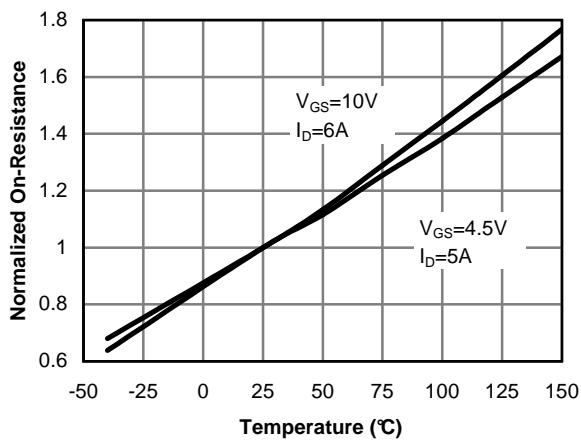


Figure 4: On-Resistance vs. Junction Temperature

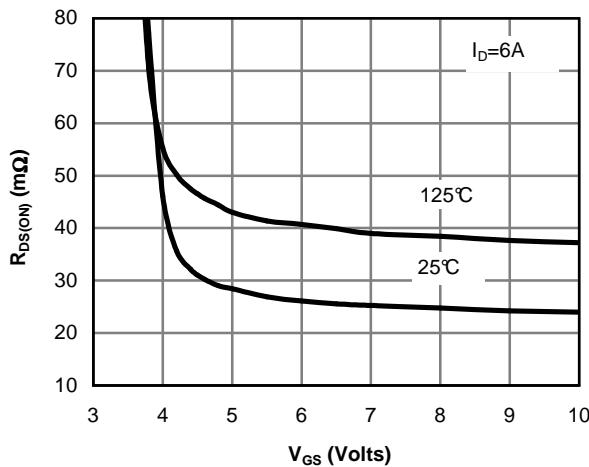


Figure 5: On-Resistance vs. Gate-Source Voltage

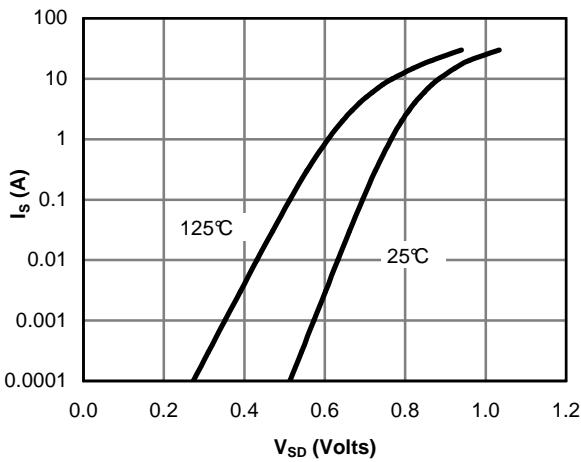


Figure 6: Body-Diode Characteristics

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: N-CHANNEL

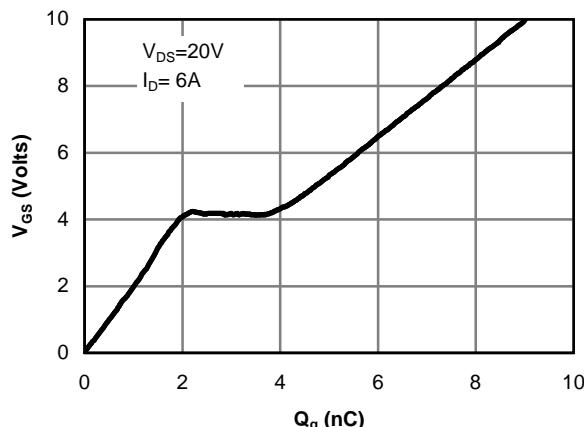


Figure 7: Gate-Charge Characteristics

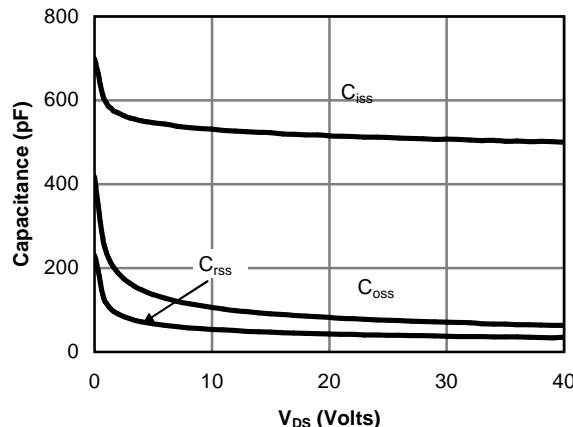


Figure 8: Capacitance Characteristics

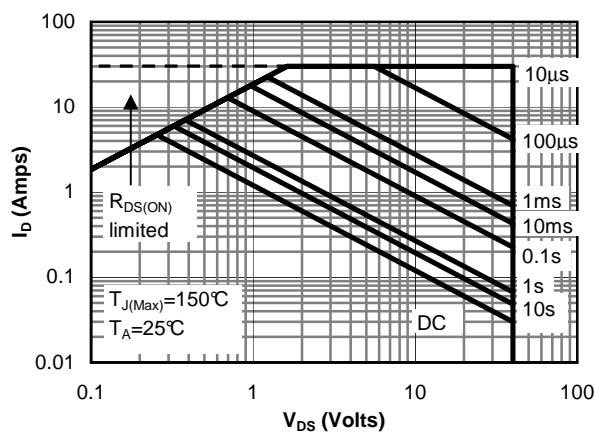


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

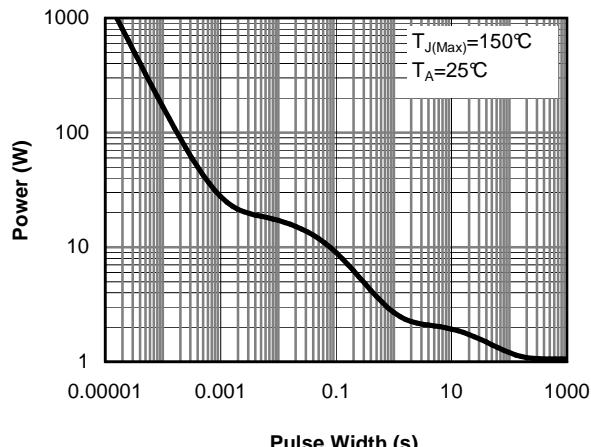


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

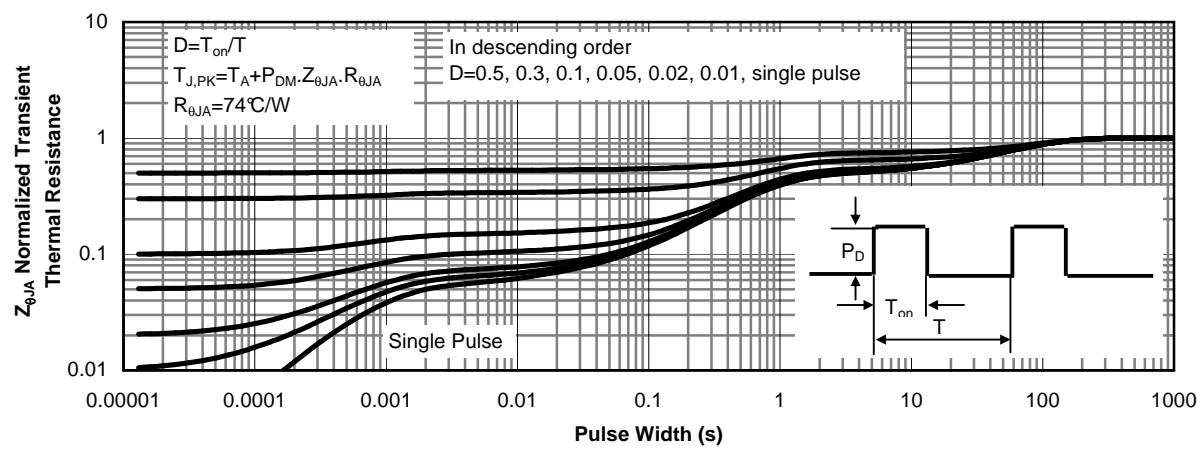


Figure 11: Normalized Maximum Transient Thermal Impedance

P-Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$I_D = -250\mu\text{A}, V_{GS}=0\text{V}$	-40			V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{DS} = -40\text{V}, V_{GS}=0\text{V}$			-1	$\mu\text{A}$
		$T_J=55^\circ\text{C}$			-5	
$I_{\text{GSS}}$	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}= \pm 20\text{V}$			$\pm 100$	nA
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D = -250\mu\text{A}$	-1.7	-2	-3	V
$I_{\text{D(ON)}}$	On state drain current	$V_{GS} = -10\text{V}, V_{DS} = -5\text{V}$	-30			A
$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$V_{GS} = -10\text{V}, I_D = -5\text{A}$			39	$\text{m}\Omega$
		$V_{GS} = -4.5\text{V}, I_D = -4\text{A}$			50	
$g_{\text{FS}}$	Forward Transconductance	$V_{DS} = -5\text{V}, I_D = -5\text{A}$		13		S
$V_{\text{SD}}$	Diode Forward Voltage	$I_S = -1\text{A}, V_{GS}=0\text{V}$		-0.76	-1	V
$I_S$	Maximum Body-Diode Continuous Current				-2	A
<b>DYNAMIC PARAMETERS</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{GS}=0\text{V}, V_{DS} = -20\text{V}, f=1\text{MHz}$	750	940	1175	pF
$C_{\text{oss}}$	Output Capacitance			97		pF
$C_{\text{rss}}$	Reverse Transfer Capacitance			72		pF
$R_g$	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$		14		$\Omega$
<b>SWITCHING PARAMETERS</b>						
$Q_g(-10\text{V})$	Total Gate Charge	$V_{GS} = -10\text{V}, V_{DS} = -20\text{V}, I_D = -5\text{A}$		17	22	nC
$Q_g(-4.5\text{V})$	Total Gate Charge			7.9	10	nC
$Q_{gs}$	Gate Source Charge			3.4		nC
$Q_{gd}$	Gate Drain Charge			3.2		nC
$t_{\text{D(on)}}$	Turn-On DelayTime	$V_{GS} = -10\text{V}, V_{DS} = -20\text{V}, R_L = 4\Omega, R_{\text{GEN}} = 3\Omega$		6.2		ns
$t_r$	Turn-On Rise Time			8.4		ns
$t_{\text{D(off)}}$	Turn-Off DelayTime			44.8		ns
$t_f$	Turn-Off Fall Time			41.2		ns
$t_{rr}$	Body Diode Reverse Recovery Time	$I_F = -5\text{A}, dI/dt = 100\text{A}/\mu\text{s}$		21	27	ns
$Q_{rr}$	Body Diode Reverse Recovery Charge	$I_F = -5\text{A}, dI/dt = 100\text{A}/\mu\text{s}$		14		nC

A: The value of  $R_{\text{JJA}}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design. The current rating is based on the  $t \leq 10\text{s}$  thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The  $R_{\text{JJA}}$  is the sum of the thermal impedance from junction to lead  $R_{\text{JL}}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using <300  $\mu\text{s}$  pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The SOA curve provides a single pulse rating .

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: P-CHANNEL

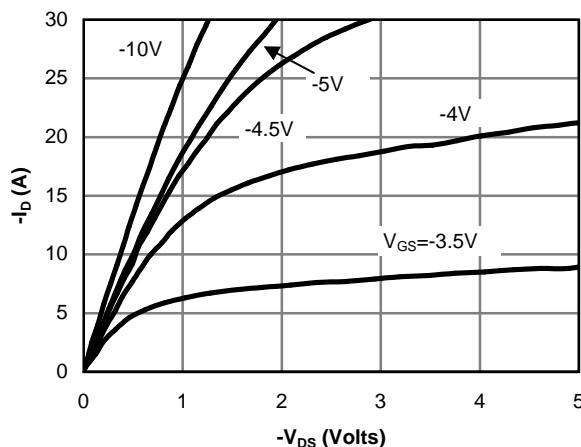


Fig 12: On-Region Characteristics

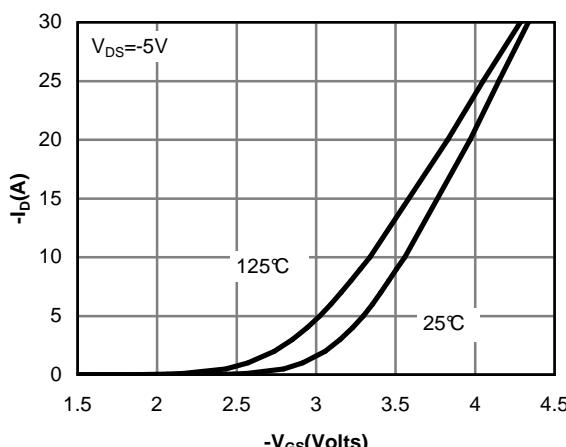


Figure 13: Transfer Characteristics

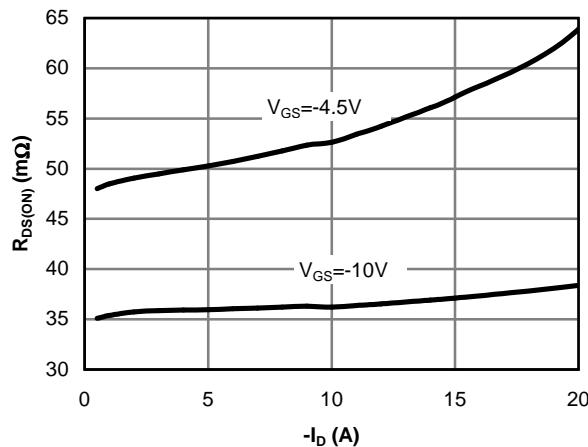


Figure 14: On-Resistance vs. Drain Current and Gate Voltage

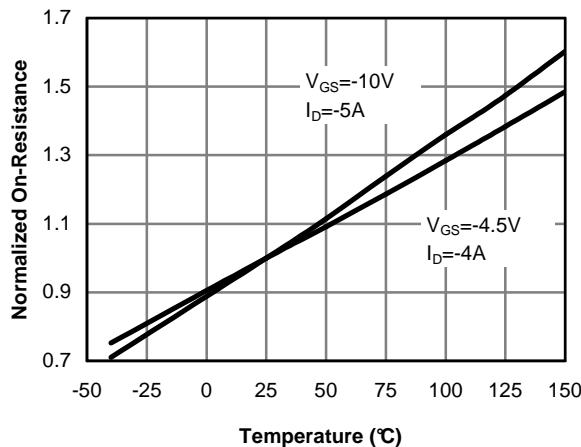


Figure 15: On-Resistance vs. Junction Temperature

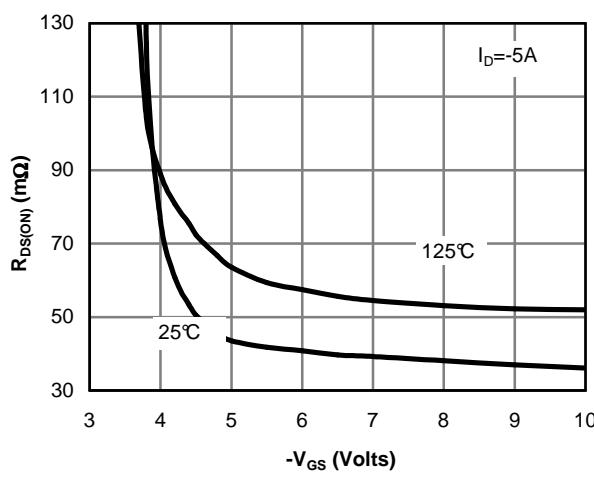


Figure 16: On-Resistance vs. Gate-Source Voltage

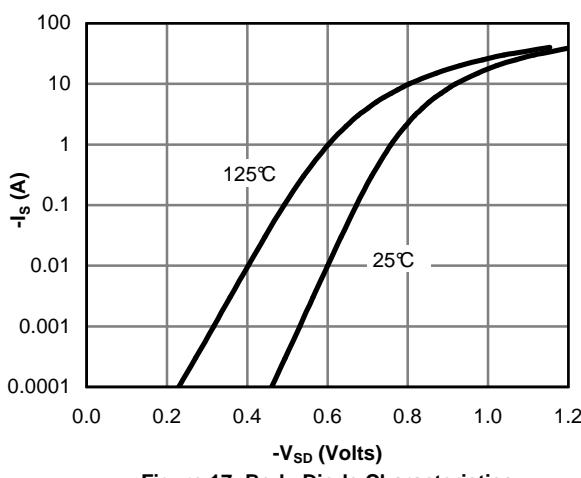
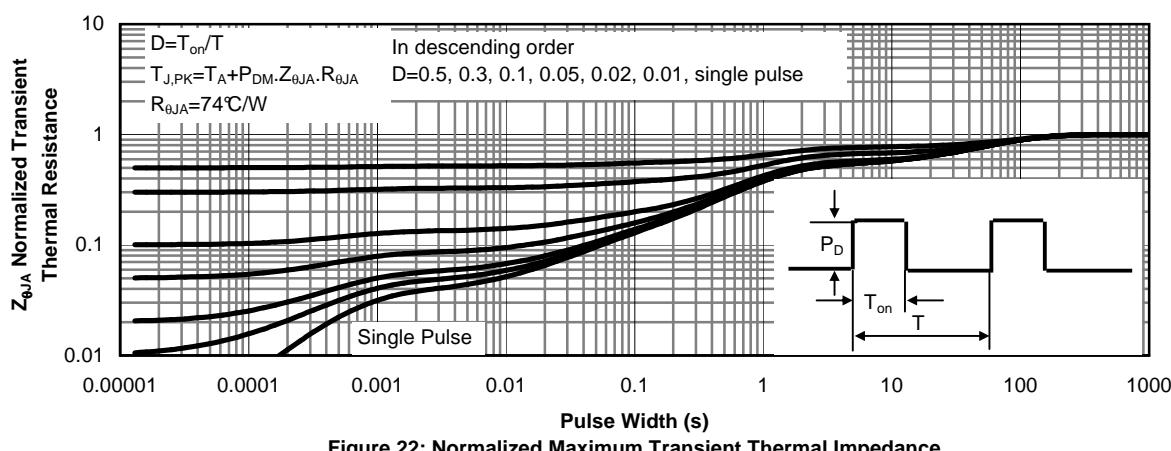
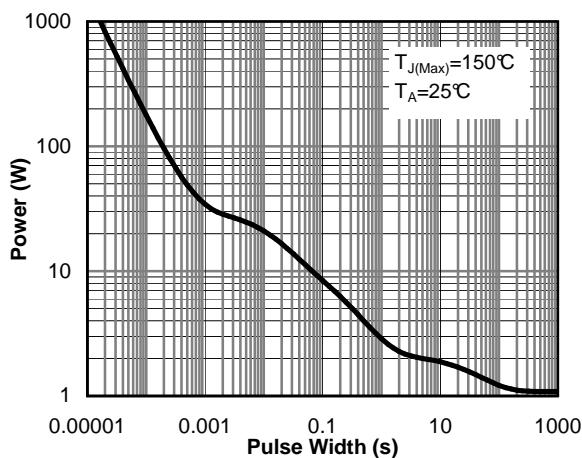
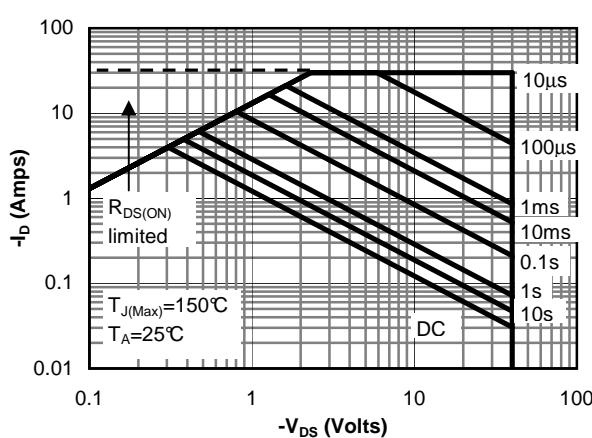
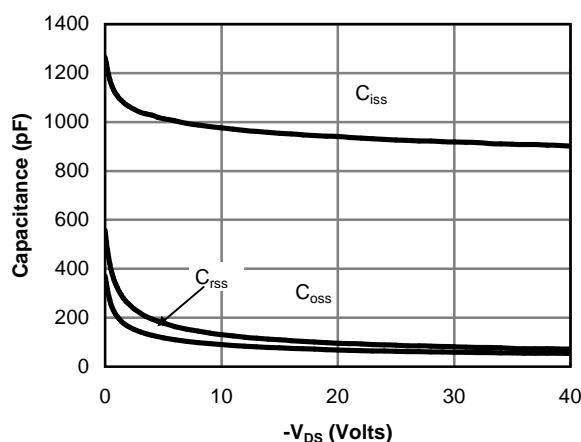
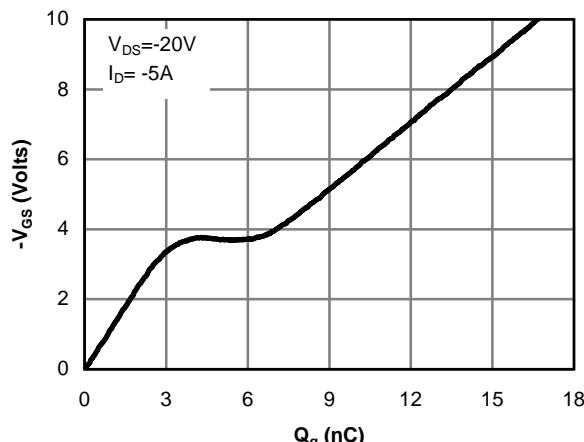


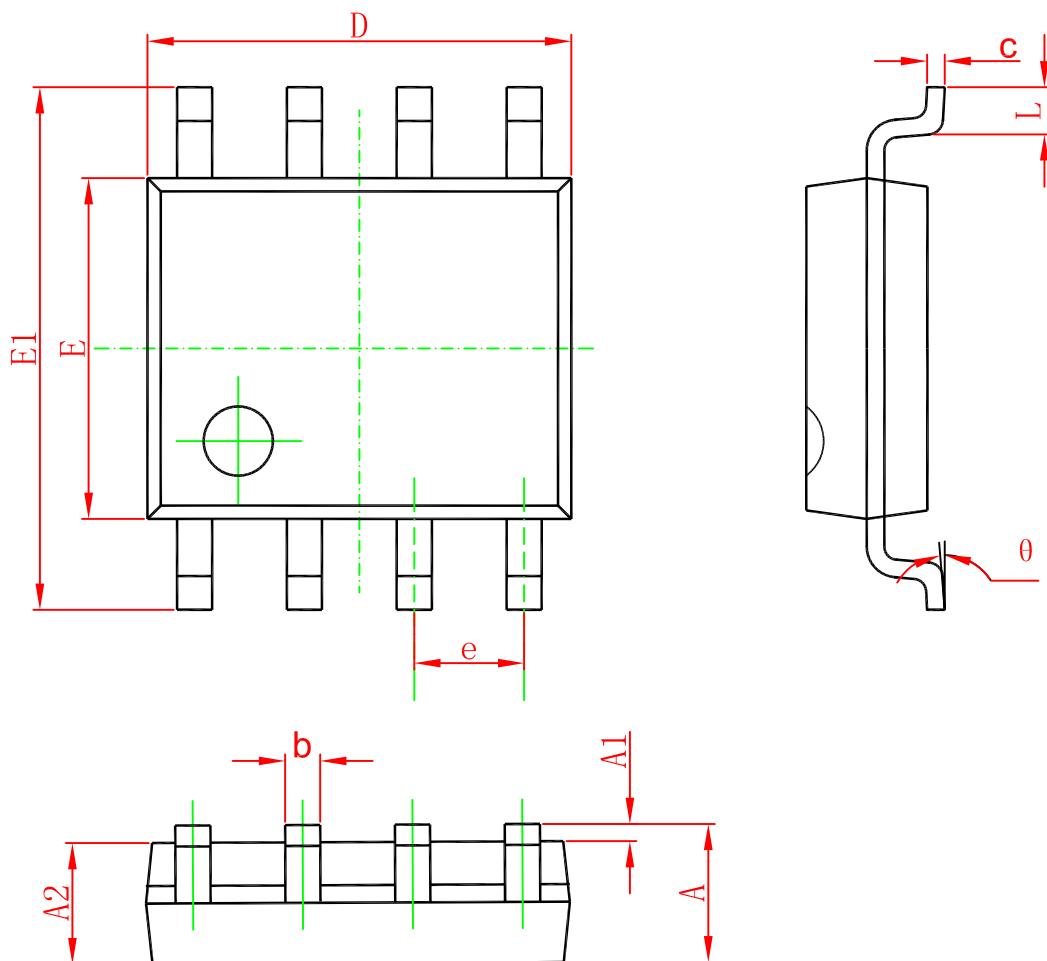
Figure 17: Body-Diode Characteristics

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: P-CHANNEL



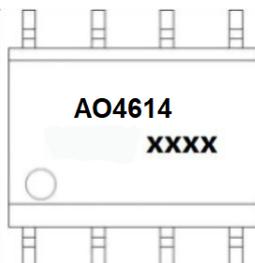
## PACKAGE OUTLINE DIMENSIONS

SOP-8



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°

## Marking



## Ordering information

Order code	Package	Baseqty	Deliverymode
AO4614	SOP-8	3000	Tape and reel